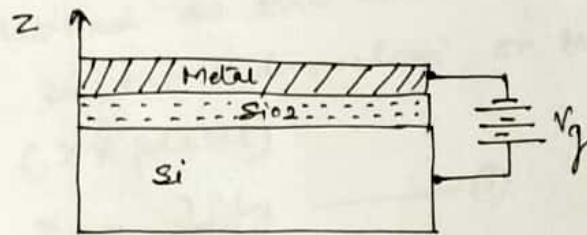


Integral Quantum Hall effect

①

The Hall effect based on classical considerations, gives a good account of the electrical transport in metals and semiconductors. But this classical magneto-conductivity scenario undergoes a spectacular transformation under quantum conditions of temperature and magnetic field in a two dimensional conductivity channel.

K. von Klitzing, Dorda and Pepper observed that such a channel is formed at the oxide interface in a metal-oxide-semiconductor (MOS) transistor when a gate voltage is applied between the metal and the semiconductor.

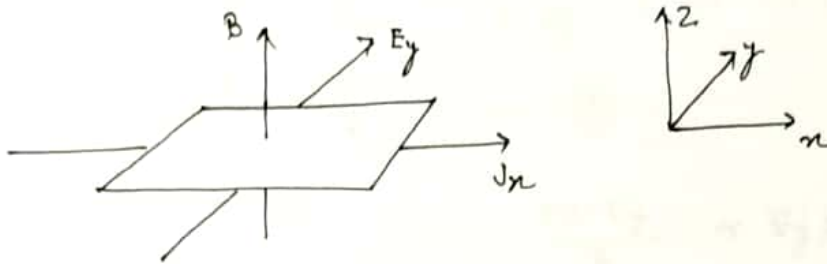
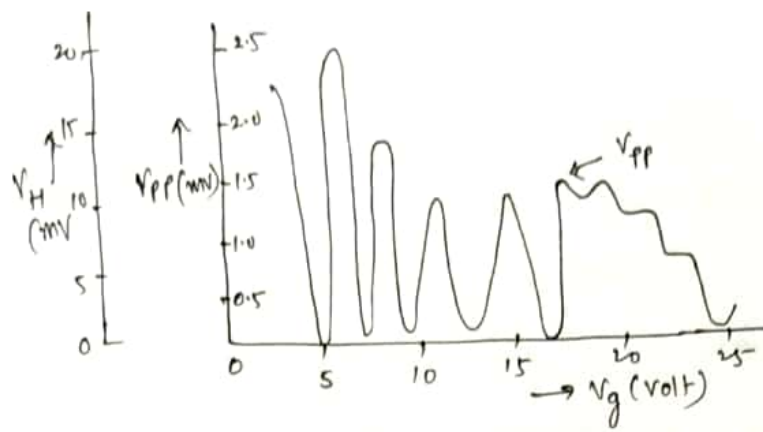


The fascinating aspect of their observation is that the Hall resistance R_H varies with the magnetic field according to the following rule;

$$R_H = \frac{h}{i e^2} \quad \text{where 'i' is an integer (} i = 1, 2, 3, \dots \text{)}$$
$$\text{or } \sigma_H = i \frac{e^2}{h}$$

The phenomenon expressed by this rule, where the Hall conductance is quantised in units of $\frac{e^2}{h}$, is called the Integral Quantum Hall effect (IQHE)

In the original experiment a constant current of 1 μ A was forced to flow between the source and drain in the presence of a magnetic field of 18 Tesla at 1.5 Kelvin.



Consider a surface current density \vec{J}_n in the x -direction defined as the current crossing a line of unit length in the y -direction on the oxide interface in (xy plane)

$$I_n = J_n l_y \quad \text{--- (1)}$$

If n is the total electron density per unit area of the x - y plane

$$J_n = n e v_d \quad \text{--- (2)}$$

$v_d \rightarrow$ drift velocity of electron in x -direction.

In the description of Hall effect, a current in a specimen with mobile charge carriers is produced when the specimen is placed in a region of mutually crossed electric and magnetic fields. The flow of current in a direction orthogonal to both the fields is detected on closing the circuit. If electric field \vec{E}_y and magnetic field \vec{B} act along y - and z -directions, respectively

$$J_n = \sigma_{nx} E_x + \sigma_{ny} E_y = \sigma_{ny} E_y \quad \text{--- (3)}$$

(when $E_x = 0$)

and drift velocity

$$v_d = \frac{E_y}{B} \quad \text{--- (4)}$$

Here σ_{xy} denotes conductivity tensor in the plane of two dimensional channel. Writing the resistivity ρ_{xy} as Hall resistance ρ_H

$$\rho_H = \frac{V_H}{I_n} = \frac{E_y l_y}{j_n l_y} \quad [\text{using (4)}] \quad \left[\begin{array}{l} \text{as } v_H \text{ developed along} \\ \text{y-direction so} \\ \frac{E_y}{l_y} v_H = E_y \quad \text{or} \\ v_H = E_y l_y \end{array} \right]$$

$$\text{or } \rho_H = \frac{E_y}{B j_n} \quad \text{--- (5)}$$

from (2) and (4) $j_n = \frac{ne \cdot E_y}{B}$ or $E_y = \frac{B \cdot j_n}{ne}$ --- (6)

using (5) and (6) $\rho_H = \frac{B \cdot j_n}{ne} \cdot \frac{1}{j_n} = \frac{B}{ne}$ --- (7)

This represent the resistance of a channel of unit thickness.

In a magnetic field \vec{H} , an electron experiences a Lorentz force. \perp to the field.

$$m \frac{d^2 \vec{r}}{dt^2} = e \left(\frac{\partial \vec{r}}{\partial t} \right) \times \vec{B} \quad \text{--- (i)}$$

In x-y plane the inward directed magnetic force $e(\vec{v} \times \vec{H})$ give rise to motion in a circle of radius r with a cyclotron frequency. ω

$$\frac{m v^2}{r} = e v B \quad \text{or} \quad \frac{v}{r} = \frac{e B}{m}$$

$$\text{and } \omega = \frac{2\pi}{T} = \frac{2\pi}{\frac{2\pi r}{v}} = \frac{v}{r}$$

$$\Rightarrow \omega = \frac{B e}{m} \quad \text{or} \quad \frac{v}{r} = \frac{B e}{m} \quad \text{or} \quad B = \frac{m v}{e r}$$

as m, e, v are constant we have.

$$B \propto \frac{1}{r} \quad \text{--- (ii)}$$

\Rightarrow when B is large, we have very small orbit radii.

According to correspondence principle the energy (4) associated to these small radii orbit is quantized.

$$E_{\perp} = \left(n + \frac{1}{2}\right) \hbar \omega_c, \text{ where } n \text{ is an integer.}$$

In a thin film of thickness d_z , the k_z (Law to the surface) also get quantized in units of $\frac{2\pi}{d_z}$

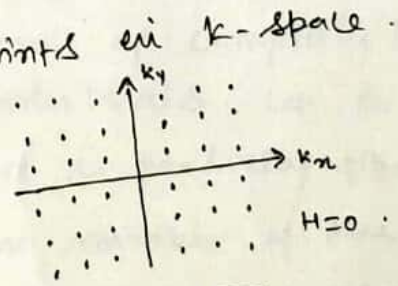
Thus we have $E_{\perp} = \left(n + \frac{1}{2}\right) \hbar \omega_c$ $k_z = 0, 1, 2, \dots$ (x-y plane)

and $(k_z)_l = \left(\frac{2\pi}{d_z}\right) l$ $l = 0, \pm 1, \pm 2, \dots$ (z axis)

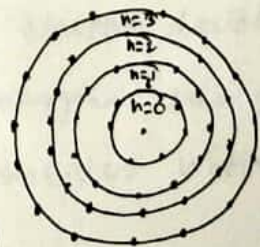
So we have $E_{nl} = E_{\perp} + E_z = \left(n + \frac{1}{2}\right) \hbar \omega_c + \left(\frac{\hbar^2 k_z^2}{2m}\right) l$

At low temperature $T \rightarrow 0$, for small d_z , the levels are separated enough to stability the electron states. These quantized states are called Landau levels.

In the absence of magnetic field the allowed electron states in two dimensions are represented by $\frac{\hbar^2}{2m} (k_x^2 + k_y^2)$ and shown by points in k-space.



When sufficient strong magnetic field is applied these points corresponding to states of free electrons may be viewed as restricted to concentric circles in $k_x k_y$ plane. The successive circles corresponds to successive values of the quantum number 'n' in the energy $\left(n + \frac{1}{2}\right) \hbar \omega_c$. The area in between the successive circles are



$$\Delta A(k) = 2\pi k \Delta k = 2\pi \frac{m}{\hbar^2} \Delta E$$

$$= \frac{2\pi m}{\hbar^2} \hbar \omega_c = \frac{2\pi m \omega_c}{\hbar} = \frac{2\pi m}{\hbar} \frac{\hbar e \hbar \omega_c}{m \hbar} = \frac{2\pi e \omega_c}{\hbar} \quad (iii)$$

$$\left. \begin{aligned} E &= \frac{\hbar^2 k^2}{2m} \text{ or } k^2 = \frac{2mE}{\hbar^2} \\ \Delta k \Delta k &= \frac{2m \Delta E}{\hbar^2} \\ k \Delta k &= \frac{m \Delta E}{\hbar^2} \end{aligned} \right\}$$

Thus the area in between successive circles are proportional to B as $\frac{2\pi e}{h}$ are constant. (5)

The number of states on each circle is constant and is equal to the area between the circles times the number of states per unit area when $B=0$. The number of states per unit area when $B=0$ are $\left(\frac{L}{2\pi}\right)^2$

Thus the no. of states on each circle is

$$\frac{2\pi B e}{h} \times \left(\frac{L}{2\pi}\right)^2 = \frac{2\pi B e}{h} \frac{L^2}{4\pi^2} = \frac{B e L^2}{2\pi h} = \frac{B e L^2}{2\pi \cdot \frac{h}{2\pi}} = \frac{B e L^2}{h}$$

It gives the number of electron states or levels. That coalesce into a single magnetic level as soon as even a small magnetic field is switched on. This describes the degeneracy of a Landau level, therefore degeneracy per unit area in x-y plane is.

$$D(B) = \frac{B e^2}{h} / L^2 = \frac{B e}{h} \quad \text{--- (IV)}$$

When the applied magnetic field is so strong that $\hbar \omega_c \gg k_B T$. We can talk in terms of completely filled or ~~partially~~ completely empty Landau levels. Let B_i is critical field at which no level is partially filled and 'i' is the magnetic quantum number of the highest-occupied level. When the electron density on the oxide ^{inter} surface is adjusted by varying the gate voltage so that the Fermi level coincides with the level 'i'

$$n = i D(B_i) \quad \text{--- (V)}$$

$$= i \frac{B_i e}{h}$$

from equation (6) $j_n = \frac{n \cdot e E_y}{B}$ where 'n' is the density of charge carriers. (VI)

$$RH = \frac{E_y}{j_x B_z} = \frac{j_x}{\sigma_{xy}} \cdot \frac{1}{j_x B_z} = \frac{E_{xy}}{B_z} \quad \text{using eq. (3)} \quad (6)$$

$$\text{Thus } \sigma_{xy} = \frac{j_x}{E_y} = \frac{n e v_{drift}}{B_z} = i \frac{B_z e}{h} \cdot \frac{e}{B_z} \quad \text{using (v)}$$

$$\text{or } \sigma_{xy} = i \frac{e^2}{h} \quad \text{--- (vi)}$$

Thus the Hall conductivity of the two dimensional system in the quantum limit (Landau orbit) is quantized in integral multiples of e^2/h . These narrow levels are lying below the Fermi level E_F .

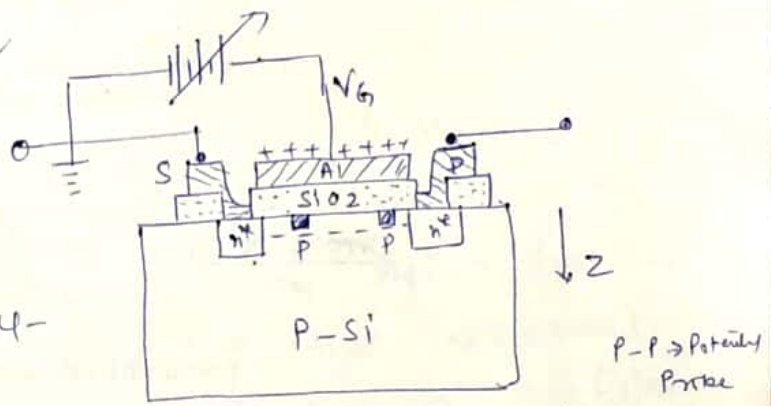
Under the condition the electron can undergo either elastic or inelastic scattering. The elastic scattering would lead to an electron to go in the same Landau level. But it is not permitted by Pauli exclusion principle, since all possible final states of equal energy are occupied. The inelastic collision can be possible with the scattering of electron to a high level by absorbing the energy from some source. One possible source may be phonon, but at low temperature and with $h\nu_c \gg k_B T$, there are hardly any phonon whose energy could compare with the large energy interval $h\nu_c$. Thus inelastic ~~energy~~ collisions are ~~to be~~ ruled out and electron mean path is greatly enhanced. The results in the occurrence of the voltage minima at V_{pp} .

Quantum hall effect demonstration

A two dimensional electron system exists in a metal oxide semiconductor field effect transistor i.e. MOSFET. In an n-channel MOSFET the Fermi level E_F can be made to enter the conduction band by applying a large positive gate voltage V_g . This creates an inversion layer which forms a two dimensional electron gas. These inversion layers are formed at the interface between a semiconductor and an insulator or in between two semiconductors, with one of them acting as insulator. The system in which the quantum hall effect was discovered has Si for semiconductors and SiO_2 for the insulator. Recently the semiconductor-semiconductor system $GaAs - Al_xGa_{1-x}As$, the later playing the role of the insulator, has also used to study this effect.

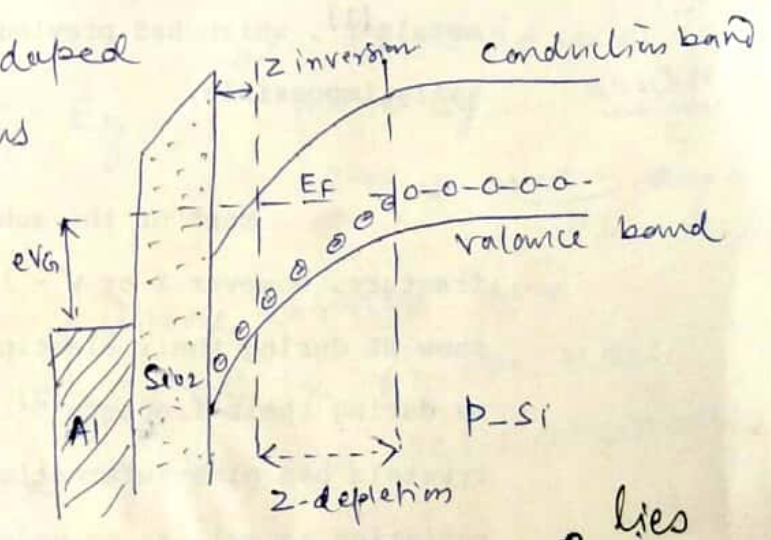
The principle of inversion layer is quite simple. It is arranged that an electric field perpendicular to the interface attracts electrons from the semiconductor to it. These electrons sit in the quantum well created by this field and the motion perpendicular to the interface is quantized and thus the motional degree of freedom in this direction is ~~restricted~~ frozen out. The result is a net two dimensional system of electrons.

The source of attracting electric field differs in the two systems. In the silicon case the insulating oxide layer is made relatively thick (5000 Å) and a metallic electrode (Al) plated over it. This electrode is positively charged by applying the positive charged external gate voltage, which array of the electric field permits providing a better control over the density of sheet of electrons attracted to the interface.



The later self-consistent-potential seen by the electrons can be conveniently by the picture of band bending. That is to say, the periodic lattice potential gives rise to energy bands and slowly varying electric potential is then regarded as bending of these bands.

The semiconductor is doped with p-type i.e. some electrons of the valence band have become bound to acceptor dopant-impurities leaving empty states, holes. The lowest-energy holes are at the top of the valence band. This means that electrons close to the top of that band attracted to the surface first fill up these holes



the Fermi level ~~lies~~ lies

states leaving a net negative charge of three dimensional density equal to the acceptor density. However if there is sufficient gate voltage, the bottom of the conduction band will become lower than the Fermi level, and if there is a way for them to get there the electrons will occupy states in the part of the conduction band bands below the Fermi level near the insulator-semiconductor interface. This layer is called inversion layer, with the bottom of the conduction band below the top of the valence band. Inverting the normal order. It is also possible to use a n-type semiconductor and reverse the sign of the gate voltage to achieve inverted hole states.

Let a current j_n flow along x-direction and a magnetic field H be applied along the z-direction. Then

$$j_n = \frac{n_e e c}{H} E_y$$

as $j_n = -n_e c u_x$ and $\sigma E_y = -\frac{c u_x}{H} H_z$

$$\text{sum } j_n = +\frac{n_e e c}{H^2} \sigma E_y$$

or $j_n = \sigma_{xy} E_y$

where n_e is the density of charge carriers and $\sigma_{xy} = \left(\frac{n_e e c}{H}\right)$, which relate E_y and j_n is the Hall conductivity. The reciprocal of this is Hall resistivity.

ρ_{xy} and $R_H = \frac{E_y}{j_n H_z} = \frac{j_n}{\sigma_{xy}} \cdot \frac{1}{j_n H_z} = \frac{\rho_{xy}}{H_z}$ is the Hall coefficient. with H the carrier concentration $n_e = n_L = q_L$ where $\sigma = 1, 2, 3, \dots$

Thus.

$$\sigma_{xy} = \frac{j_n}{E_y} = \frac{n_e \cdot e c}{H} = \frac{g_L v e c}{H}$$

(8)

$$\sigma_{xy} = \frac{e^2 v}{4\pi} \cdot \frac{e c}{H} = v \left(\frac{e^2}{h} \right)$$

But $g_L = \frac{e}{hc} H \Rightarrow n_e = g_L v = \frac{e^2 H v}{hc}$

$$\sigma_{xy} = \frac{n_e e c}{H} = v \left(\frac{e^2}{h} \right) \text{ where } v = 1, 2, 3, \dots$$

Thus the Hall conductivity of the two dimensional system (inversion layer) in the quantum limit (small orbit) is quantized in integral multiples of e^2/h . These v narrow levels are lying below E_F i.e. Fermi level.

Klitzing received the 1985 Nobel prize for observing the quantum Hall effect by measuring R_{xy} in Silicon MOSFET and so e^2/h (or e^2/hc) accurately. As $R_{xy} \propto 1/n_e$ the sign and value of n_e is found by measuring R_{xy} .

$$\left[\begin{aligned} \sigma_{xy} &= \frac{n_e e c}{H} \\ \sigma_{xy} &= \frac{1}{R_{xy}} = \frac{H e c}{n_e e c} \end{aligned} \right]$$

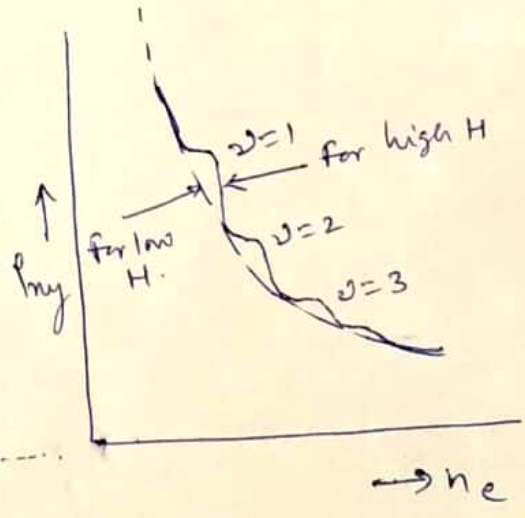
When the potential difference is applied across the SiO_2 channel in a MOSFET, an inversion layer (25-50 Å thick) is formed at the SiO_2-Si interface. The density of electrons in the layer depends on the potential difference. The inversion layer region is a rectangular box of thickness 'd'. The lowest excitation energy $\left[\frac{\hbar^2 (k_z)^2}{2m} \right]$ for the motion of the electrons along z-axis is about 20 milli eV. Below 10k temperature, the typical energies are only about

1 milli ev. Thus the motion law to the layer (9) is frozen out and it behaves as a two dimensional layer.

Klitzing et al varied ν_g (that is n_e) with a constant source-drain current I_n and measured the Hall voltage, which gave ρ_{xy} . For small H , the expected smooth monotonic decrease of ρ_{xy} with n_e , $\rho_{xy} \propto 1/n_e$ was found.

The fig. shows the plot of ρ_{xy} vs n_e at small H .

Dashed curve indicates $\rho_{xy} \propto 1/n_e$ and large H (quantum Hall effect) showing steps according to $[\rho_{xy} = \frac{h}{2e^2}] \nu = 1, 2, 3, \dots$



To have $\hbar\omega > kT$ or $\frac{\hbar H e}{mc} > kT$

or $\frac{\hbar e}{mc} H > kT$ or $1.6 \times 10^{-20} H > 1.38 \times 10^{-16} T$

for $T = 4.2k$ we get $H > 42$ kilogauss. when $T = 1.5k$ and $H = 180$ kilo gauss was kept, they found that over certain ranges of n_e (surface charge density) the ρ_{xy} remains constant (Hall steps). these steps are the manifestation of quantization and occur at $\rho_{xy} = h/2e^2$.

the value of e^2/hc is found to be $1/137.0353 \cdot 2\pi$ is (10)
is also found that, unlike the ordinary Hall effect,
the normal resistivity measured by potentiating
probes vanishes, as in a superconductor, in
the region of Hall steps. If E_F for some
value of ν is between two Landau levels, the density
of states at E_F is zero and an inversion layer
of carrier cannot be scattered. Then the flow
of current is lossless - the normal
resistivity vanishes at Hall steps.

Integral Quantum Hall effect

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